

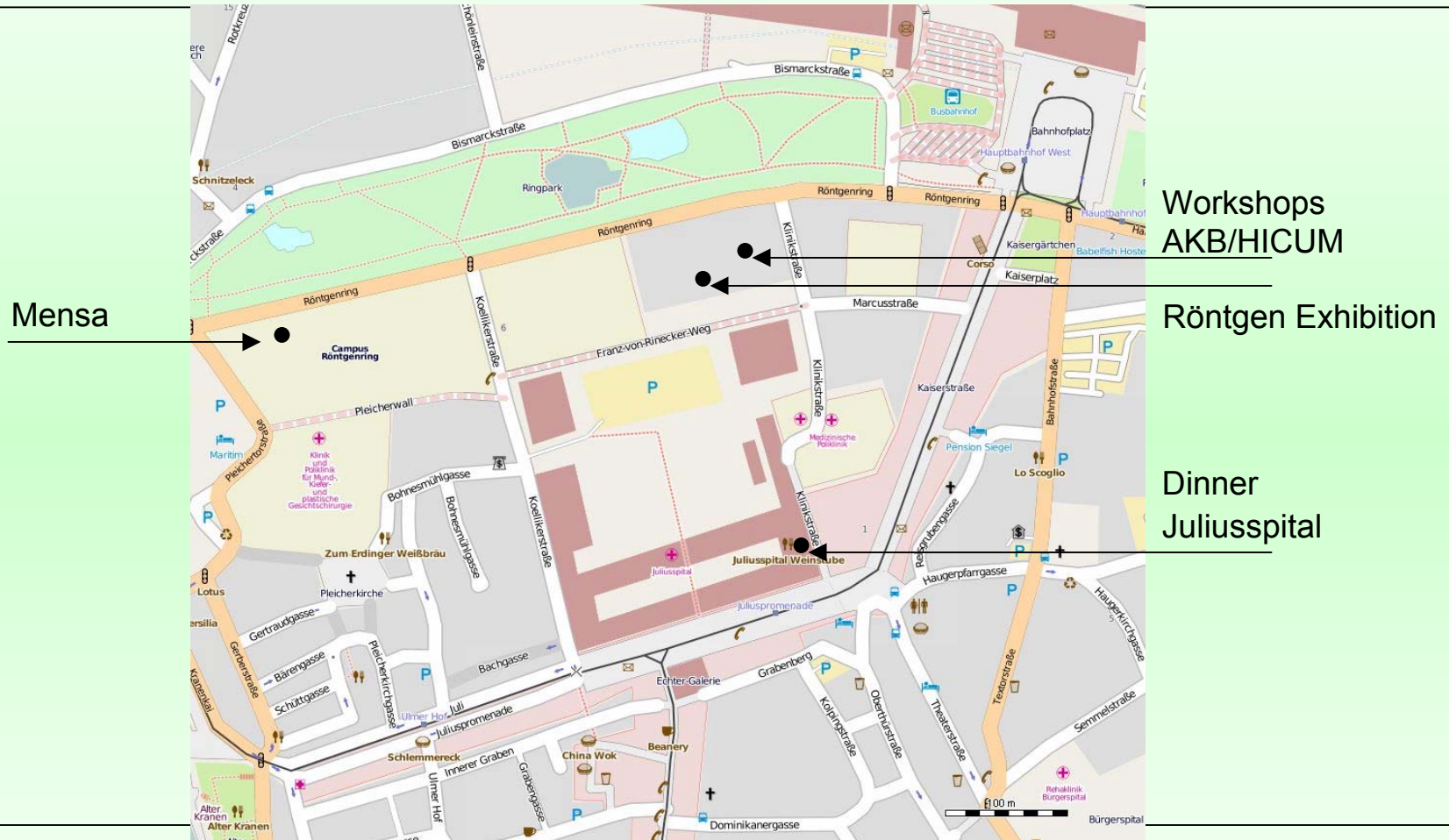
Würzburg FHWS

AKB-Workshop
22. October 2009

HICUM - Workshop
23. October 2009

Time	Topic	Company	Speaker	Room
09:30-10:00	Arrival and prearrangement			106D
10:00-10:10	Opening	FH-Würzburg	Baureis	106D
10:10-10:20	Member matters	Infineon	Berkner	106D
10:20-10:55	Thermal capacitance c_{th} - its determination and influence on transistor and circuit performance	IHP	Fischer	106D
10:55-11:30	Thermal impedance measurement and modeling including thermal coupling	FH-Würzburg	Baureis	106D
11:30-12:00	Improvement of SGP modelling using additional devices	NXP	Wilhelmi	106D
12:00-13:00	Lunch			Mensa

13:00-13:40	Pulsed S-Parameter-Measurements using ICCAP	Infineon	Hanke	106D
13:40-14:20	Extraction of RE and its temperature dependence from RF measurements	AMS	Huszka	106D
14:20-15:00	Coffee Break			106D
15:00-15:40	Investigations on lateral PNP BiCMOS transistors for a special application in DVD PDICs	XFAB	Wald	106D
15:40-16:20	HICUM/L0 v1.2: application to mmW devices	ST	Celi	106D
16:20-17:00	Tips and Tricks for Daily Modeling Work	Infineon	Berkner	106D
18:00-19:00	Röntgen Exhibition	City Council	Felgenhauer	005B
19:00(19:30)-22:00	Dinner			Juliusspital



Mensa
Augenklinik



Workshops
AKB/HICUM

Röntgen Exhibition

Dinner
Juliusspital
Weinstube

